

# MOSFET - N-Channel POWERTRENCH®

30 V, 8.5 A, 23 m $\Omega$ 

# **FDS8884**

#### **Description**

This N-Channel MOSFET has been Designed Specifically to improve the overall efficiency of DC/DC Converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $R_{DS(on)}$  and fast switching speed.

#### **Features**

- Max  $R_{DS(on)} = 23 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 8.5 \text{ A}$
- Max  $R_{DS(on)} = 30 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 7.5 \text{ A}$
- Low Gate Charge
- 100% R<sub>G</sub> Tested
- These Device is Pb-Free and RoHS Compliant

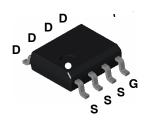
#### **MOSFET MAXIMUM RATINGS** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain to Source Voltage	100	V
V <sub>GS</sub>	Gate to Source Voltage	±20	V
I <sub>D</sub>	Drain Current Continuous (Note 1a) Pulsed	8.5 40	Α
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 2)	32	mJ
P <sub>D</sub>	Power Dissipation T <sub>C</sub> = 25°C	2.5	W
	Derate Above 25°C	20	mW/°C
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

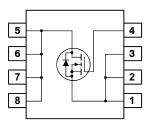
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance Junction to Ambient (Note1a)	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Case (Note 1)	25	



SOIC8, CASE 751EB



#### **MARKING DIAGRAM**

FDS8884 ALYW O

FDS8884 = Specific Device Code
A = Assembly Location
L = Lot Traceability Code
YW = Date Code (Year and Week)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
FDS8884	SO-8 (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

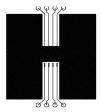
#### **ELECTRICAL CHARACTERISTICS** $T_J = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Charac	cteristics	•	•	•	•	
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30	-	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C	-	23	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125°C	-	-	1 250	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V	_	-	±100	nA
On Charac	cteristics (Note 3)		•			
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.2	1.7	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 380 μA, Referenced to 25°C	-	-4.9	-	mV/°C
R <sub>DS(on)</sub>	Drain to Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.5 A	-	19	23	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 7.5 A	_	23	30	
		$V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}, T_J = 125^{\circ}\text{C}$	_	26	32	
Dynamic (	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	475	635	pF
C <sub>oss</sub>	Output Capacitance		-	100	135	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	65	100	pF
$R_{g}$	Gate Resistance	f = 1 MHz	-	0.9	1.6	Ω
Switching	Characteristics (Note 3)					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 8.5 A,	-	5	10	ns
t <sub>r</sub>	Rise Time	$V_{GS} = 10 \text{ V}, R_{GS} = 32 \Omega$	-	9	18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	42	68	ns
t <sub>f</sub>	Fall Time	7	-	21	34	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.5 A	-	9.2	13	nC
Qg	Total Gate Charge	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 5 V, I <sub>D</sub> = 8.5 A	_	5.0	7	nC
Q <sub>gs</sub>	Gate to Source Gate Charge		_	1.5	-	nC
$Q_{gd}$	Gate to Drain Charge		-	2.0	-	nC
Drain-Sοι	rce Diode Characteristics and Maximum	Ratings	_			
$V_{SD}$	Source to Drain Diode Forward Voltage	I <sub>SD</sub> = 8.5 A	_	0.9	1.25	V
		I <sub>SD</sub> = 2.1 A	_	0.8	1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 8.5 A, di/dt = 100 A/μs	-	-	33	ns
Q <sub>rr</sub>	Reverse Recovery Charge	7		1	20	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### NOTES:

1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a).50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b).105 °C/W when mounted on a 0.4 in<sup>2</sup> pad of 2 oz copper.



c).125 °C/W when mounted on a minimum pad

Scale 1:1 on letter size paper

- 2. Starting T<sub>J</sub> = 25°C, L = 1 mH, I<sub>AS</sub> = 8 A, V<sub>DD</sub> = 27 V, V<sub>GS</sub> =10 V. 3. Pulse Test: Pulse Width  $\leq$  300  $\mu s$ , Duty Cycle  $\leq$  2.0%.

#### **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25 °C unless otherwise noted)

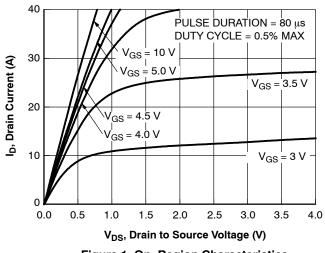


Figure 1. On-Region Characteristics

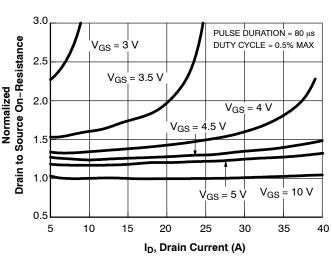


Figure 2. Normalized On-Resistance vs.

Drain Current and Gate Voltage

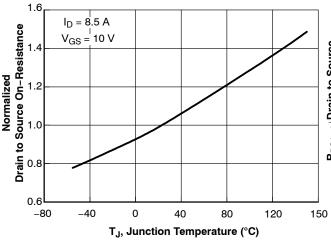


Figure 3. Normalized On–Resistance vs
Junction Temperature

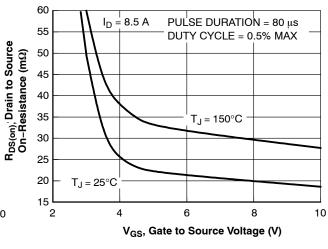


Figure 4. On-Resistance vs Gate to Source Voltage

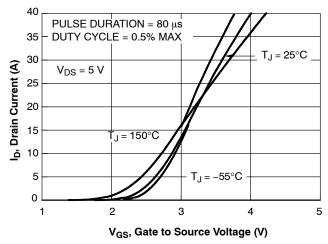


Figure 5. Transfer Characteristics

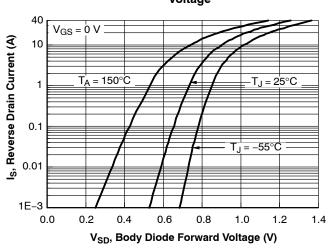
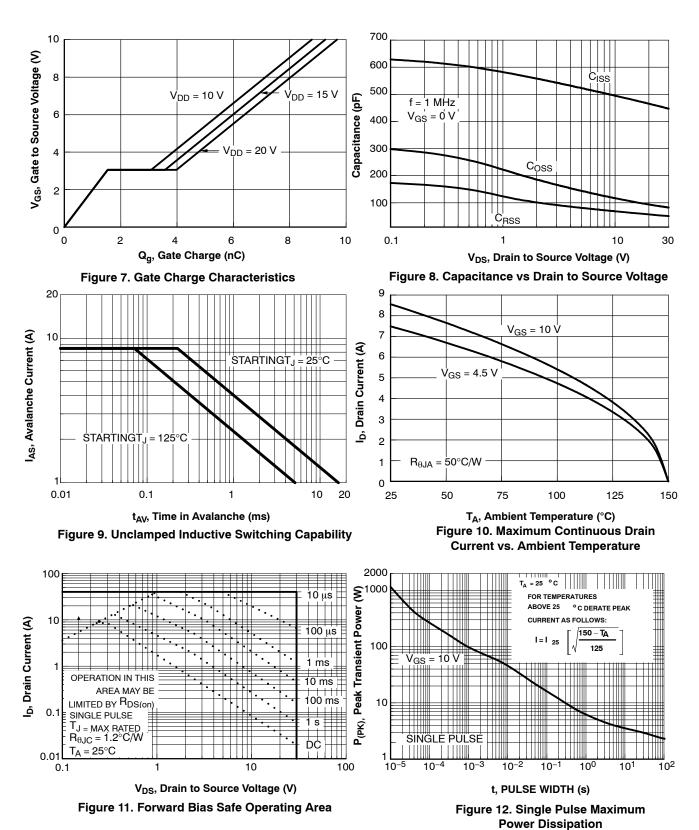


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

#### **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25 °C unless otherwise noted) (CONTINUED)



## **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25 °C unless otherwise noted) (CONTINUED)

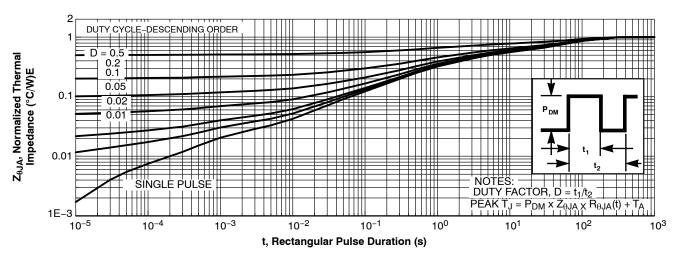


Figure 13. Transient Thermal Response Curve



# CASE 751EB **ISSUE A DATE 24 AUG 2017** ·4.90±0.10 → -0.65(0.635)В 6.00±0.20 5.60 3.90±0.10 PIN ONE **INDICATOR** 1.27 1.27 0.25(M) LAND PATTERN RECOMMENDATION В SEE DETAIL A 0.175±0.075 0.22±0.03 С 1.75 MAX 0.10 0.42±0.09 OPTION A - BEVEL EDGE $(0.43) \times 45^{\circ}$ R0.10 GAGE PLANE OPTION B - NO BEVEL EDGE R0.10-0.25 NOTES: A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AA. B) ALL DIMENSIONS ARE IN MILLIMETERS. **SEATING PLANE** C) DIMENSIONS DO NOT INCLUDE MOLD 0.65±0.25 FLASH OR BURRS. D) LANDPATTERN STANDARD: SOIC127P600X175-8M (1.04)**DETAIL** À SCALE: 2:1 Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DOCUMENT NUMBER:** 98AON13735G

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